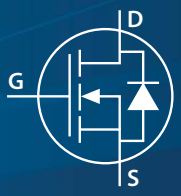
EPC2034 – Enhancement Mode Power Transistor

V_{DS} , 200 V
$R_{DS(on)}$, 10 mΩ
I_D , 48 A

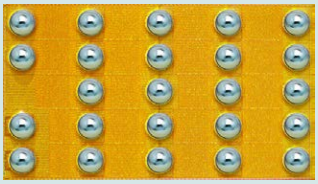


EFFICIENT POWER CONVERSION

RoHS Halogen-Free

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR}. The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Maximum Ratings			
PARAMETER		VALUE	UNIT
V_{DS}	Drain-to-Source Voltage (Continuous)	200	V
I_D	Continuous (T_A = 25°C, $R_{\theta JA}$ = 3°C/W)	48	A
	Pulsed (25°C, T_{PULSE} = 300 µs)	200	
V_{GS}	Gate-to-Source Voltage	6	V
	Gate-to-Source Voltage	-4	
T_J	Operating Temperature	–40 to 150	°C
T_{STG}	Storage Temperature	–40 to 150	



EPC2034 eGaN® FETs are supplied only in passivated die form with solder bumps.
Die Size: 4.6 mm x 2.6 mm

- High Frequency DC-DC Conversion
- Motor Drive
- Industrial Automation
- Class-D Audio

Thermal Characteristics			
PARAMETER		TYP	UNIT
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.45	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Board	3.9	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	45	

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board.
See https://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details

Static Characteristics (T_J = 25°C unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
BV_{DSS}	Drain-to-Source Voltage	V_{GS} = 0 V, I_D = 0.6 mA	200			V
I_{DSS}	Drain-Source Leakage	V_{DS} = 160 V, V_{GS} = 0 V		0.1	0.4	mA
I_{GSS}	Gate-to-Source Forward Leakage	V_{GS} = 5 V		1	7	mA
	Gate-to-Source Reverse Leakage	V_{GS} = -4 V		0.1	0.4	mA
$V_{GS(TH)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 7 mA	0.8	1.4	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance	V_{GS} = 5 V, I_D = 20 A		7	10	mΩ
V_{SD}	Source-Drain Forward Voltage	I_S = 0.5 A, V_{GS} = 0 V		1.8		V

All measurements were done with substrate connected to source.

Dynamic Characteristics (T_J = 25°C unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
C_{ISS}	Input Capacitance	V_{DS} = 100 V, V_{GS} = 0 V		950	1140	pF
C_{RSS}	Reverse Transfer Capacitance			2.3		
C_{OSS}	Output Capacitance			450	680	
$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	V_{DS} = 0 to 100 V, V_{GS} = 0 V		550		
$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			750		
R_G	Gate Resistance			0.5		Ω
Q_G	Total Gate Charge	V_{DS} = 100 V, V_{GS} = 5 V, I_D = 20 A		8.8	11	nC
Q_{GS}	Gate to Source Charge	V_{DS} = 100 V, I_D = 20 A		3		
Q_{GD}	Gate to Drain Charge			1.8		
$Q_{G(TH)}$	Gate Charge at Threshold			2.2		
Q_{OSS}	Output Charge	V_{DS} = 100 V, V_{GS} = 0 V		75	113	
Q_{RR}	Source-Drain Recovery Charge			0		

Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.
Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Figure 1: Typical Output Characteristics at 25°C

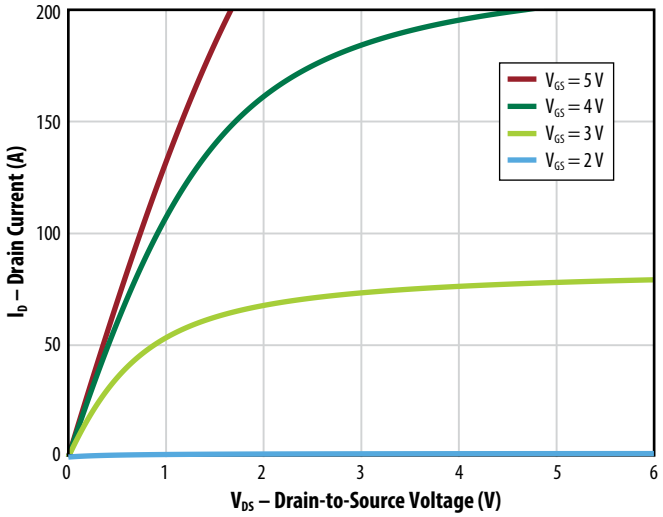


Figure 2: Transfer Characteristics

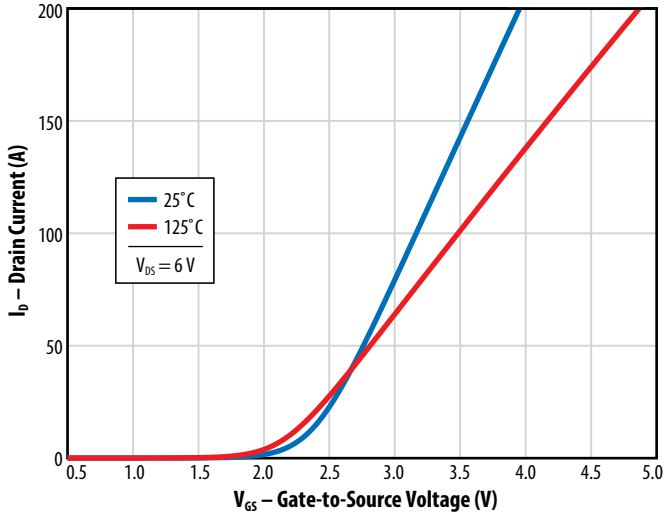


Figure 3: $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents

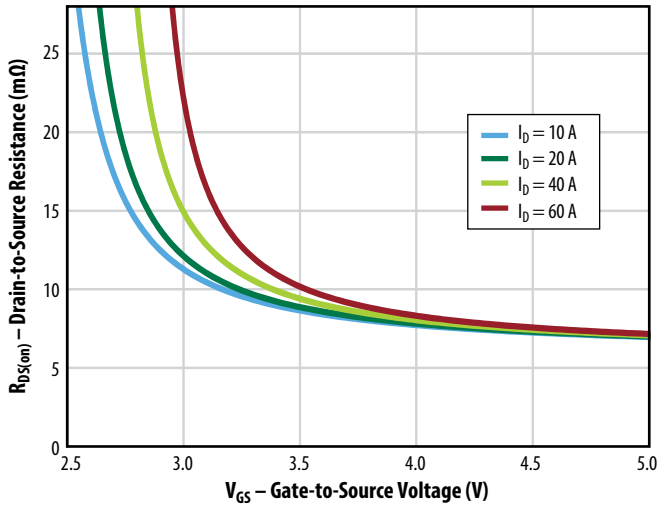


Figure 4: $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

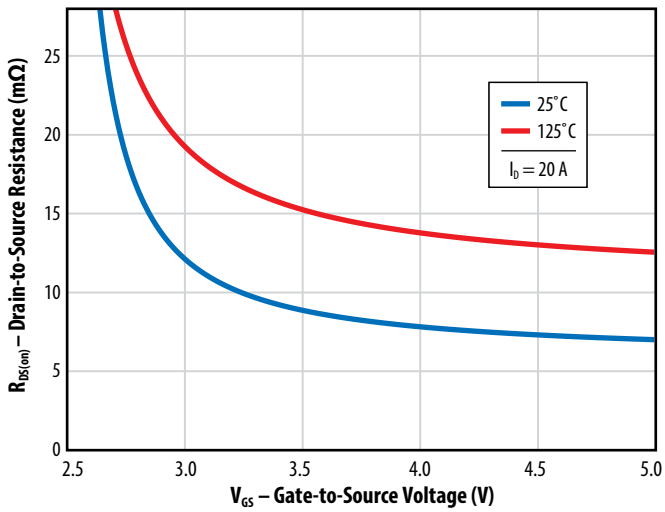


Figure 5a: Capacitance (Linear Scale)

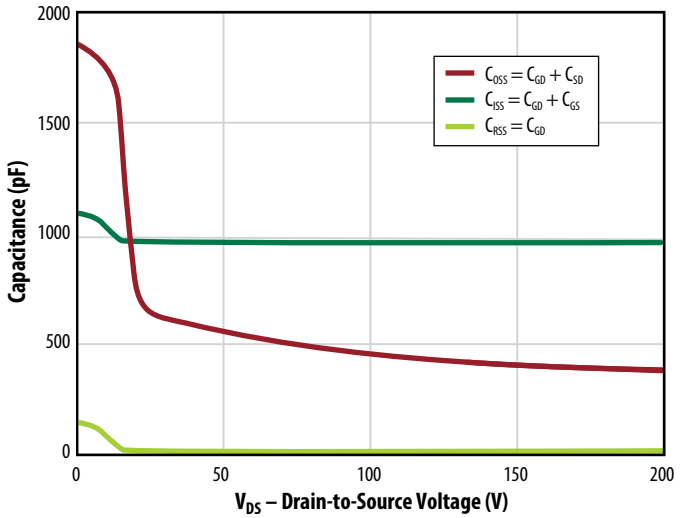


Figure 5b: Capacitance (Log Scale)

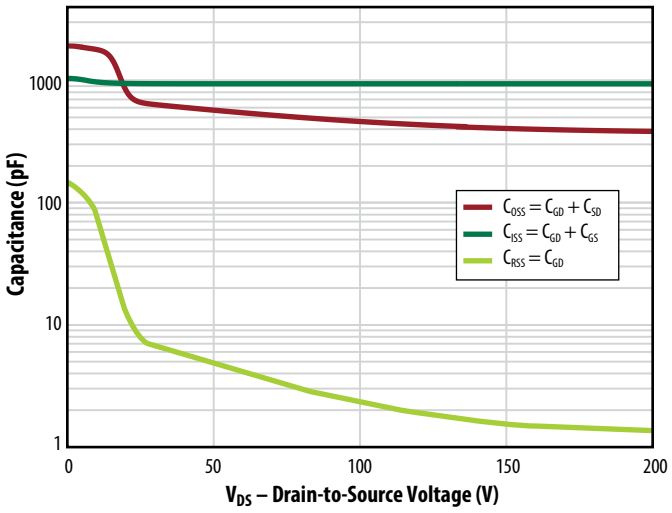


Figure 6: Gate Charge

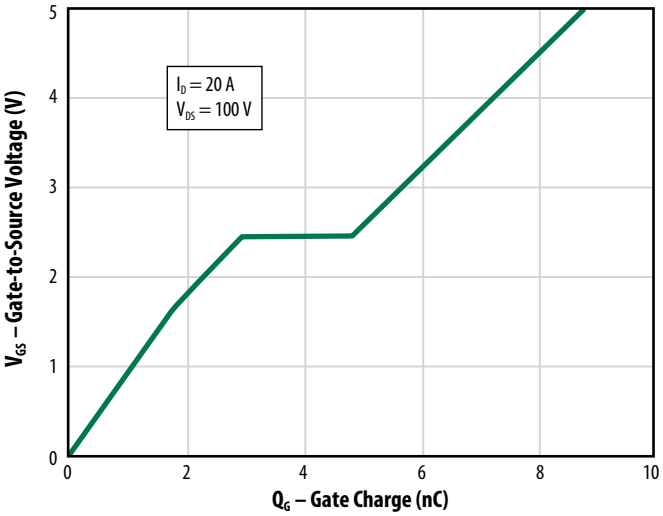


Figure 7: Reverse Drain-Source Characteristics

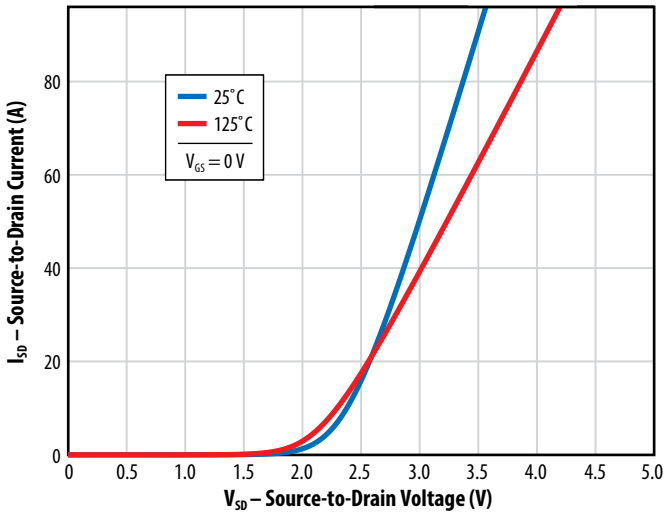


Figure 8: Normalized On-State Resistance vs. Temperature

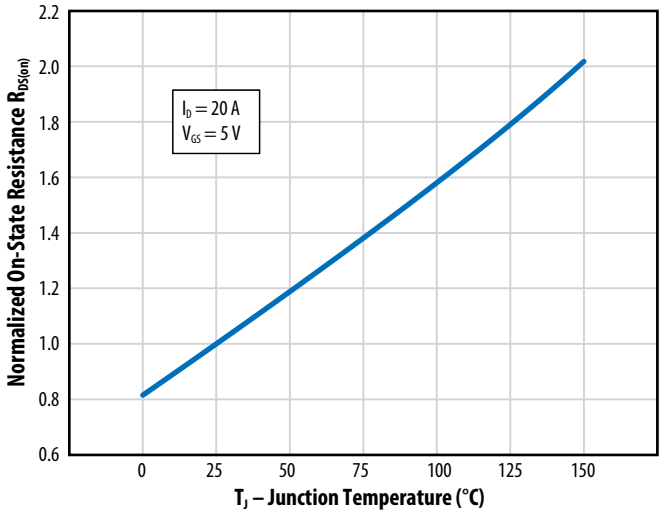
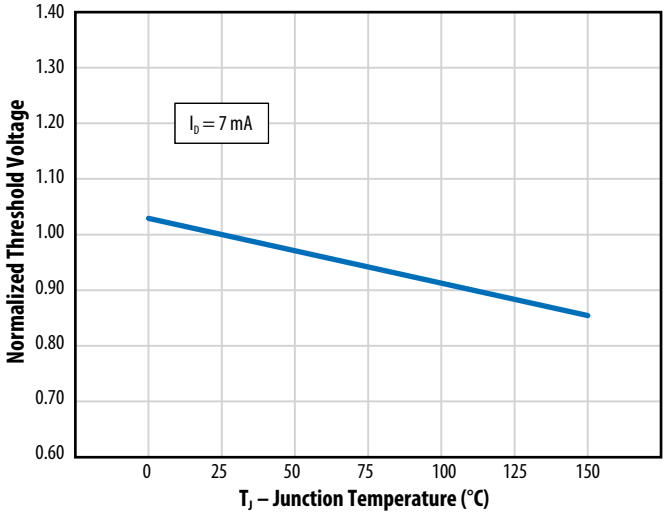


Figure 9: Normalized Threshold Voltage vs. Temperature



All measurements were done with substrate shortened to source. $T_J = 25$°C unless otherwise stated.

Figure 10: Gate Leakage Current

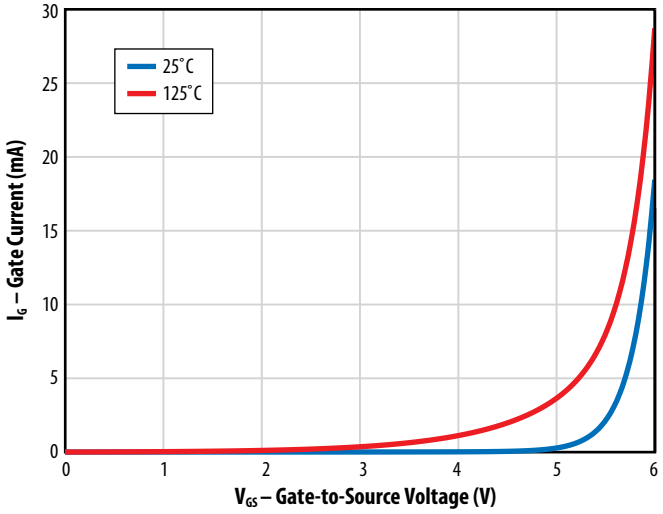


Figure 11: Safe Operating Area

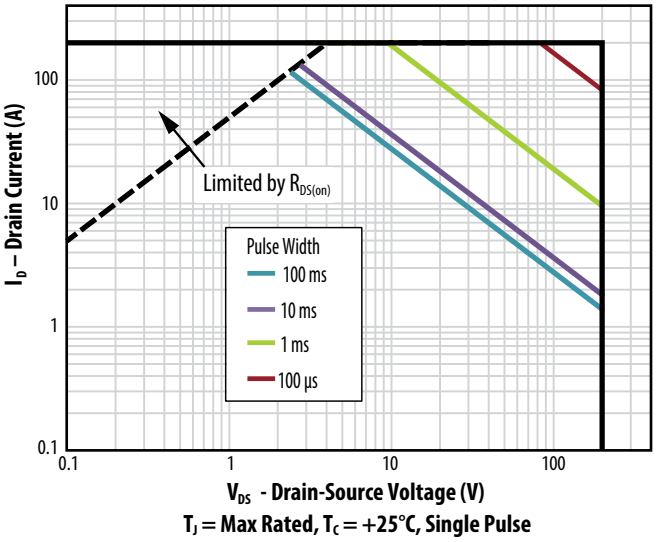
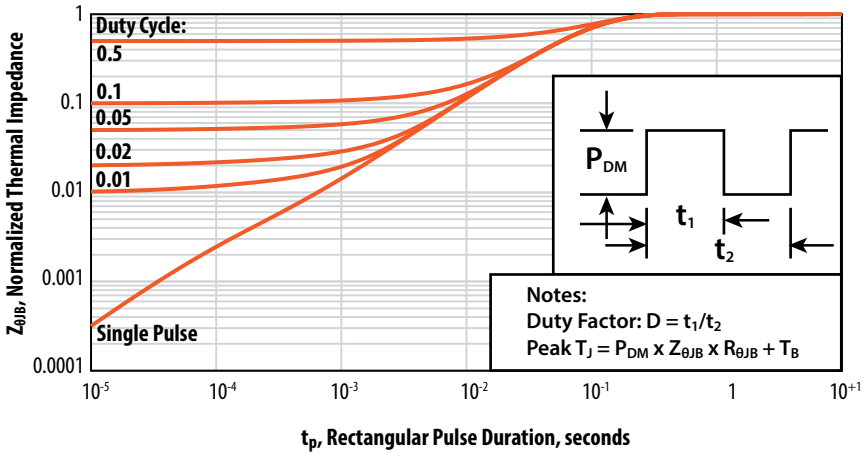
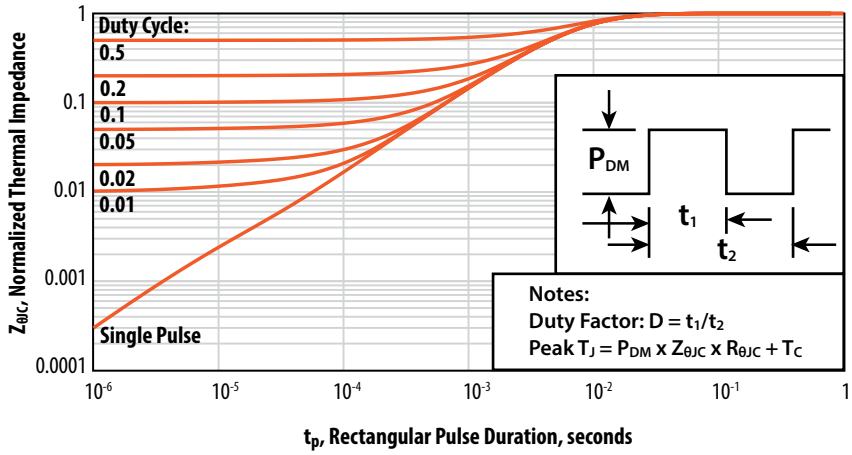


Figure 12: Transient Thermal Response Curves

Junction-to-Board

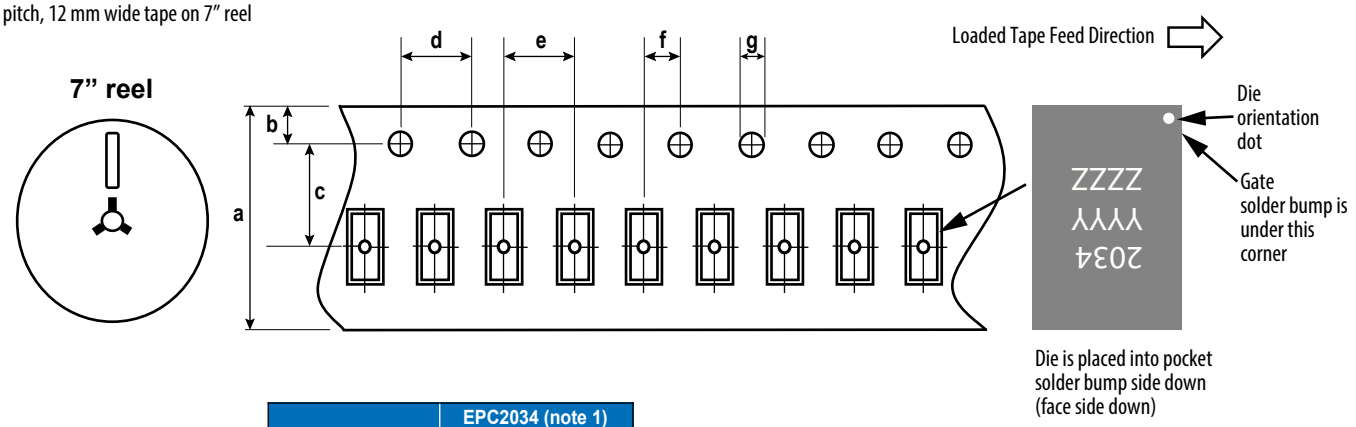


Junction-to-Case



TAPE AND REEL CONFIGURATION

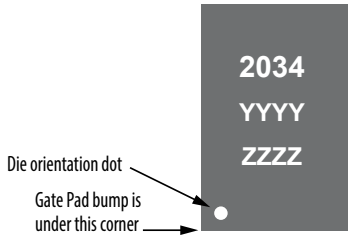
4 mm pitch, 12 mm wide tape on 7" reel



	EPC2034 (note 1)		
Dimension (mm)	target	min	max
a	12.00	11.70	12.30
b	1.75	1.65	1.85
c (note 2)	5.50	5.45	5.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (note 2)	2.00	1.95	2.05
g	1.5	1.5	1.6

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.
Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

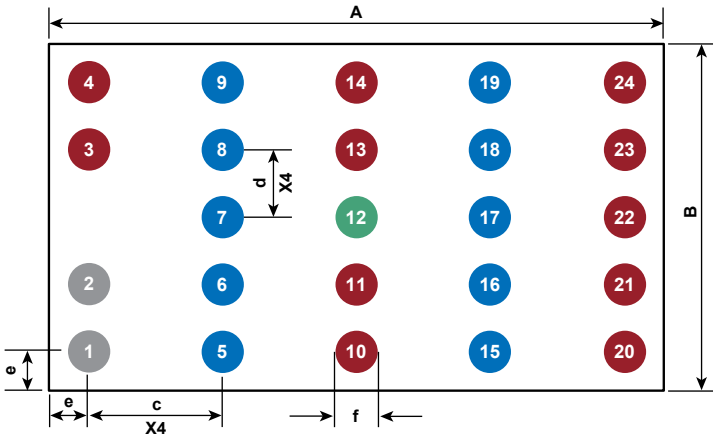
DIE MARKINGS



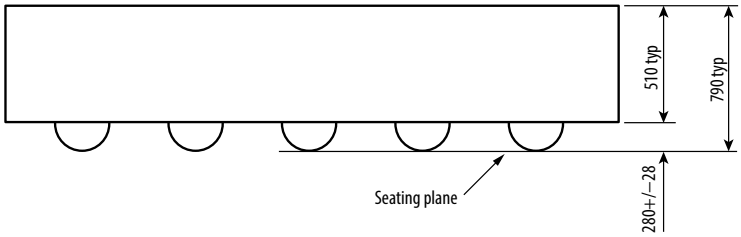
Part Number	Laser Marking		
	Part # Marking Line 1	Lot_Date Code Marking Line 2	Lot_Date Code Marking Line 3
EPC2034	2034	YYYY	ZZZZ

DIE OUTLINE

Solder Bump View



Side View



DIM	Micrometers		
	MIN	Nominal	MAX
A	4570	4600	4630
B	2570	2600	2630
c	1000	1000	1000
d	500	500	500
e	285	300	315
f	332	369	406

Pads 1 and 2 are Gate;

Pads 5, 6, 7, 8, 9, 15, 16, 17, 18, 19 are Drain;

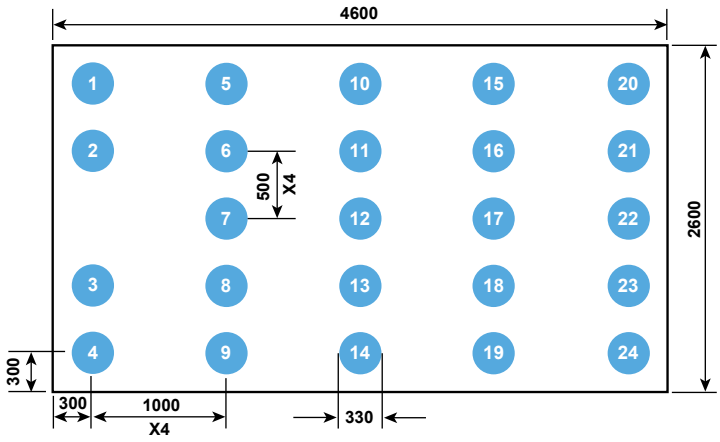
Pads 3, 4, 10, 11, 13, 14, 20, 21, 22, 23, 24 are Source;

Pad 12 is Substrate*

*Substrate pin should be connected to Source

RECOMMENDED LAND PATTERN

(units in µm)



Land pattern is solder mask defined

Solder mask opening is 330 µm

It is recommended to have on-Cu trace PCB vias

Pads 1 and 2 are Gate;

Pads 5, 6, 7, 8, 9, 15, 16, 17, 18, 19 are Drain;

Pads 3, 4, 10, 11, 13, 14, 20, 21, 22, 23, 24 are Source;

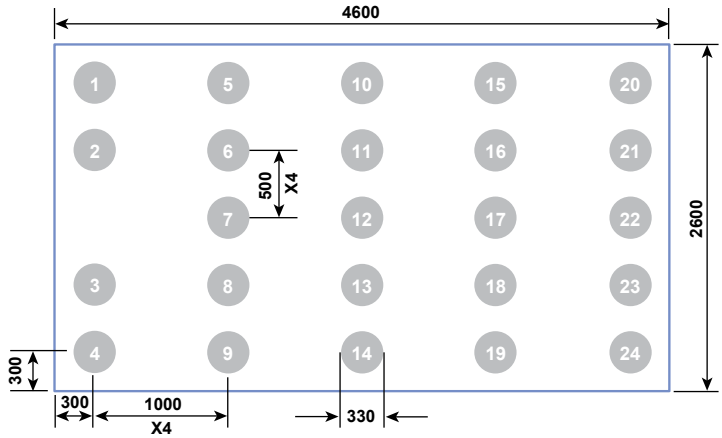
Pad 12 is Substrate*

*Substrate pin should be connected to Source

RECOMMENDED STENCIL DRAWING

(units in µm)

Option 1 : Intended for use with SAC305 Type 4 solder.



Recommended stencil should be 4 mil (100 µm) thick, must be laser cut, openings per drawing.

Additional assembly resources available at https://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx

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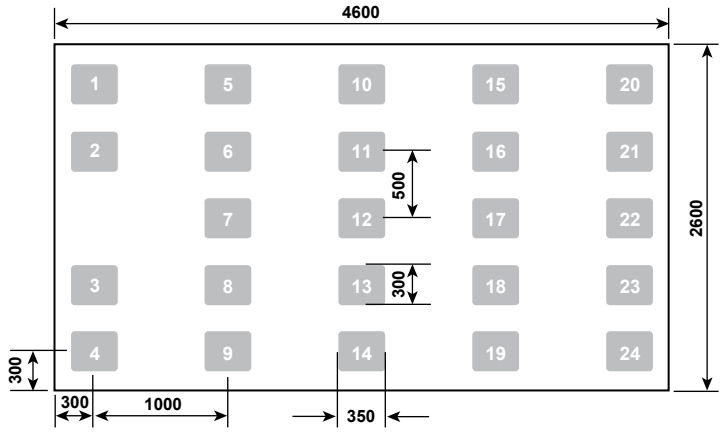
RECOMMENDED STENCIL DRAWING

(units in µm)

Option 2 : Intended for use with SAC305 Type 3 solder.



Recommended stencil should be 4 mil (100 µm) thick, must be laser cut, openings per drawing.

Additional assembly resources available at https://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx

Errata – EPC2034

Introduction:

This document describes errata to the **EPC2034 eGaN® FET** and its datasheet. This document should be used in conjunction with the datasheet and may include updates to the specifications that supersede those stated in the EPC2034 datasheet. Errata may cause a product's behavior to deviate from published specifications.

Errata List:

Input Voltage Clarifications

In the Maximum Ratings table, Maximum V_{DS} is specified at 200 V. For applications purposes, the main input DC supply voltage should be limited to 160 V_{DC}. For transient operation between 160 V and 200 V, please contact EPC at **Steve.Colino@epc-co.com**

Important Notice:

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